

Poster on solar observations of the FeXIV/FeX line ratio

During the [13th European Solar Physics Meeting](#) (held in Rhodes, Greece, September 12-16, 2011), we had the opportunity to present our work on spectroscopic observations of the Sun.

Observations of FeXIV/FeX line ratio during the extended Solar minimum (2006-2010) total Solar eclipses

Strikis Iakovos-Marios, Kouloumvakos Athanasios, Patsourakos Spiros

Abstract:

During the last four eclipses we were able to image the spectrum of the Solar Chromosphere and the Solar Corona. We report the drop of the FeXIV line intensity and the rise of the FeX line until the eclipse of 2009 and the rise of the FeXIV and from of FeX line during the total solar eclipse of 2010 from the Island of Mangaia (Cook Islands). As a result of our observations we will present that the Temperature of the Solar Corona is following the Solar Cycle and the Sunspot Cycle. In the end we attribute that the rise of the FeXIV line indicates that the new Solar Cycle has already started between the end of 2009 and beginning of 2010.



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Typical "Flash Spectrum" image: 2009 TSE Russia

Observations and Data analysis.

Coronal temperature is measured by several means of direct or indirect observations (G. Noci, 2003; Habbal, 1993) such observations in the visible, radio observation, observations on the disk in the UV spectral region and dielectronic recombination. At this point we will give more attention to the visible observations and determination of the coronal temperature from line ratios as require the analysis and the purpose of this poster. The estimation of the coronal temperature from line intensity ratios primary depends on the assumption that the density and temperature along a given line of sight where the emission of the spectral line is observed is constant. To determine the temperature from spectral line ratios we compare the line ratio deduced from the observation with those derived from theoretically from the emissivity (R. Esser, 1995; Guhathakurta, 1992).

We present the spectral and temperature analysis derived from the measurements during the total solar eclipses of 2006 (Greece), of 2008 (Russia), 2009 (China) and 2010 (Cook Islands). To estimate the coronal temperature we used the FeXIV and FeX line ratio. The reason that we used this specific line ratio is the strong coronal emission of this lines providing us an easy way of analysis and identification of this iron lines. In addition these coronal lines have been used several times in the past for temperature diagnostics and they are among the lines used by SOHO instruments.

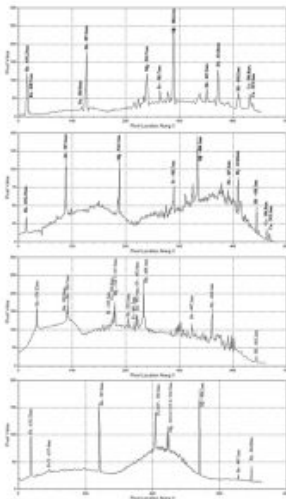


Figure 1: Top to bottom, 2006 - 2008 - 2009 and 2010 Flash Spectra. Plots by the data acquired during the TSE's

Some first order analysis of the "Flash Spectrum" data collected, have shown many differences and variations on the highly ionized lines of the Chromosphere and Transition Region through the period we study.

It seems that the lower the Solar Activity is, the less lines are detectable.

Lines	2006	2008	2009	2010
Si - 406.2nm	+	+	+	+
Si - 407.2nm	+	+	+	+
Si - 408.2nm	+	+	+	+
Si - 505.2nm	+	+	+	+
Fe - 512.2nm	+	+	+	+
Cl - 519.2nm	-	-	-	-
Si - 518.2nm	-	-	-	-
Si - 517.2nm	-	-	-	-
Si - 516.2nm	-	-	-	-
Si - 515.2nm	-	-	-	-
Fe - 513.2nm	+	+	+	+
Fe - 511.2nm	+	+	+	+
Fe - 510.2nm	+	+	+	+
Fe - 492.2nm	+	+	+	+
Fe - 491.2nm	+	+	+	+
Fe - 490.2nm	+	+	+	+
Si - 488.2nm	+	+	+	+
Si - 487.2nm	+	+	+	+
Si - 486.2nm	+	+	+	+
Si - 485.2nm	+	+	+	+
Si - 484.2nm	+	+	+	+
Si - 483.2nm	+	+	+	+
Si - 482.2nm	+	+	+	+
Si - 481.2nm	+	+	+	+
Si - 480.2nm	+	+	+	+
Si - 479.2nm	+	+	+	+
Si - 478.2nm	+	+	+	+
Si - 477.2nm	+	+	+	+
Si - 476.2nm	+	+	+	+
Si - 475.2nm	+	+	+	+
Si - 474.2nm	+	+	+	+
Si - 473.2nm	+	+	+	+
Si - 472.2nm	+	+	+	+
Si - 471.2nm	+	+	+	+
Si - 470.2nm	+	+	+	+
Si - 469.2nm	+	+	+	+
Si - 468.2nm	+	+	+	+
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Si - 453.2nm	+	+	+	+
Si - 452.2nm	+	+	+	+
Si - 451.2nm	+	+	+	+
Si - 450.2nm	+	+	+	+
Si - 449.2nm	+	+	+	+
Si - 448.2nm	+	+	+	+
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Si - 446.2nm	+	+	+	+
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Si - 430.2nm	+	+	+	+
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Si - 427.2nm	+	+	+	+
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